





TPS2640

SLVSFQ6A - NOVEMBER 2020 - REVISED JUNE 2021

TPS2640 42-V, 2-A eFuse with Integrated Reverse Input Polarity Protection

1 Features

- 4.2-V to 42-V operating voltage, 45-V absolute
- Integrated reverse input polarity protection down to -42 V
 - Zero additional components required
- Integrated back to back MOSFETs with 150-mΩ total RON
- 0.1-A to 2.23-A adjustable current limit (±5% accuracy at 1 A)
- Load protection during surge (IEC 61000-4-5) with suitable TVS
- IMON current indicator output (±8.5% accuracy)
- Low quiescent current, 300-µA in operating, 20-µA
- · Adjustable UVLO, OVP cut off, output slew rate control
- Reverse current blocking
- Available in easy-to-use 16-pin HTSSOP and 24pin VQFN packages
- Selectable current-limiting fault response options (auto-retry, latch off, circuit breaker modes)

2 Applications

- HMI power protection in factory automation
- Fire safety systems
- Electronic thermostats and video doorbells
- Industrial PCs
- Elevators

3 Description

The TPS26400 devices are compact, feature rich high voltage eFuses with a full suite of protection features. The wide supply input range of 4.2 to 42 V allows control of many popular DC bus voltages. The device can withstand and protect the loads from positive and negative supply voltages up to ±42 V. Integrated back to back FETs provide reverse current blocking feature making the device suitable for systems with output voltage holdup requirements during power fail and brownout conditions. Load, source and device protection are provided with many adjustable features including overcurrent, output slew rate and overvoltage, undervoltage thresholds. The internal robust protection control blocks along with the high voltage rating of the TPS26400 helps to simplify the system designs for Surge protection.

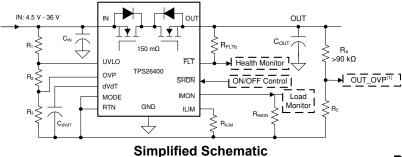
A shutdown pin provides external control for enabling and disabling the internal FETs as well as placing the device in a low current shutdown mode. For system status monitoring and downstream load control, the device provides fault and precise current monitor output. The MODE pin allows flexibility to configure the device between the three current-limiting fault responses (circuit breaker, latch off, and Auto-retry modes).

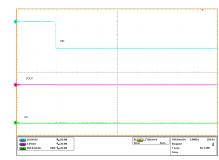
The device is available in a 5-mm × 4.4-mm 16-pin HTSSOP as well as 5-mm x 4-mm 24-pin VQFN package and are specified over a -40°C to +125°C temperature range

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE (NOM)		
TPS26400	HTSSOP (16)	5.00 mm × 4.40 mm		
TPS26400	VQFN (24)	5.00 mm × 4.00 mm		

For all available packages, see the orderable addendum at the end of the data sheet.





Reverse Polarity Protection with -42-V Input



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision * (November 2020) to Revision A (June 2021)	Page
•	Removed the "Selecting the ±Vs Supplies for TPS26610" section	28



5 Device Comparison

PART NUMBER	OVERVOLTAGE PROTECTION	OVER LOAD FAULT RESPONSE WITH MODE = OPEN
TPS26400	Overvoltage cut- off, adjustable	Circuit breaker with auto-retry

6 Pin Configuration and Functions

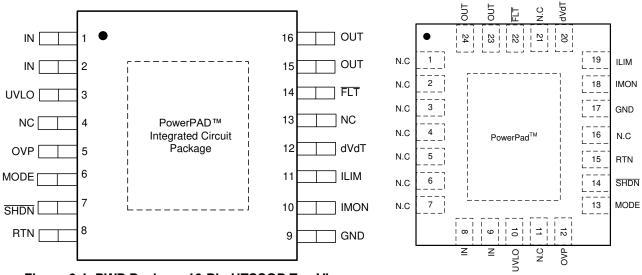


Figure 6-1. PWP Package 16-Pin HTSSOP Top View

Figure 6-2. RHF Package 24-Pin VQFN Top View

Table 6-1. Pin Functions

	PIN					
NAME	TPS2	26400	TYPE	DESCRIPTION		
NAME	HTSSOP	VQFN				
dVdT	12	20	I/O	A capacitor from this pin to RTN sets output voltage slew rate See the Hot Plug-In and In-Rush Current Control section.		
FLT	14	22	0	Fault event indicator. It is an open drain output. If unused, leave floating.		
GND	9	17	_	Connect GND to system ground.		
ILIM	11	19	I/O	A resistor from this pin to RTN sets the overload and short-circuit current limit. See the Overload and Short Circuit Protection section.		
IMON	10	18	0	Analog current monitor output. This pin sources a scaled down ratio of current through the internal FET. A resistor from this pin to RTN converts current to proportional voltage. If unused, leave it floating.		
IN	1	8	Power	Dower input and cumply valtage of the device		
IIN	2	9	rower	Power input and supply voltage of the device.		
MODE	6	13	I	Mode selection pin for over load fault response. See the Device Functional Modes section.		

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Table 6-1. Pin Functions (continued)

	PIN			. I in i unctions (continued)	
NAME	TPS2	26400	TYPE	DESCRIPTION	
NAME	HTSSOP	VQFN			
	4	1-7			
N.C		11		No connect	
N.C	13	16	_	No connect.	
		21			
OUT	15	23	Davisa	Davies subsub of the davies	
001	16	24	Power	<u> </u>	
OVP	5	12	I	Input for setting the programmable overvoltage protection threshold. An overvoltage event turns off the internal FET and asserts FLT to indicate the overvoltage fault. Connect OVP pin to RTN pin externally to select the Factory set V _(IN) overvoltage trip level. See Overvoltage Protection (OVP) section.	
PowerPadTM	_	_	_	PowerPad must be connected to RTN plane on PCB using multiple vias for enhanced thermal performance. Do not use PowerPad as the only electrical connection to RTN. For Programmable overvoltage clamp, connect the resistor ladder from Vout to OVP to RTN.	
RTN	8	15	_	Reference for device internal control circuits.	
SHDN	7	14	I	Shutdown pin. Pulling SHDN low makes the device to enter into low power shutdown mode. Cycling SHDN pin voltage resets the device that has latched off due to a fault condition.	
UVLO	3	10	ı	Input for setting the programmable undervoltage lockout threshold. An undervoltage event turns off the internal FET and asserts FLT to indicate the power-failure. Connect UVLO pin to RTN pin to select the internal default threshold.	



7 Specifications

over operating free-air temperature range (all voltages referred to GND (unless otherwise noted))(1)

7.1 Absolute Maximum Ratings

		MIN	MAX	UNIT
IN , IN-OUT		-45	45	V
IN , IN-OUT (10 ms transient), T _A = 25°C		- 55	55	V
[IN, OUT, FLT, UVLO, SHDN] to RTN	Input voltage	-0.3	45	V
[OVP, dVdT, ILIM, IMON, MODE] to RTN		-0.3	5	V
RTN		-45	0.3	V
I _{FLT} , I _{dVdT} , I _{SHDN}	Sink current		10	mA
I _{dVdT} , I _{ILIM} , I _{IMON}	Source current	Internally limited		
T	Operating junction temperature	-40	150	°C
$\left T_{J}\right $	Transient junction temperature	-65	T _(TSD)	°C
T _{stg}	Storage temperature	-65	150	°C

⁽¹⁾ Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±1000	V
V (ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±250	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

over operating free-air temperature range (all voltages referred to GND (unless otherwise noted))

7.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
IN		-42		42	
UVLO, OUT, FLT	Input voltage	0		42	V
OVP, dVdT, ILIM, IMON, SHDN		0		4	
ILIM	Resistance	5.36		120	kΩ
IMON	resistance	1			K22
IN, OUT	External capacitance	0.1			μF
dVdT	Ехіеттаї сарасітансе	10			nF
T _J	Operating junction temperature	-40	25	125	°C

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7.4 Thermal Information

		TPS	TPS2640		
	THERMAL METRIC ⁽¹⁾	PWP (HTSSOP)	RHF (VQFN)	UNIT	
		16 PINS	24 PINS		
R _{θJA}	Junction-to-ambient thermal resistance	38.6	30.2	°C/W	
R _{θJC(top)}	Junction-to-case (top) thermal resistance	22.7	20.8	°C/W	
R _{θJB}	Junction-to-board thermal resistance	18.2	7.6	°C/W	
Ψ ЈТ	Junction-to-top characterization parameter	0.5	0.2	°C/W	
Ψ ЈВ	Junction-to-board characterization parameter	18	7.6	°C/W	
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	1.5	1.7	°C/W	

For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

Product Folder Links: TPS2640



7.5 Electrical Characteristics

 $-40^{\circ}\text{C} \le \text{T}_{\text{A}} = \text{T}_{\text{J}} \le +125^{\circ}\text{C}, \ V_{(\text{IN})} = 24 \text{ V}, \ V_{(\overline{\text{SHDN}})} = 2 \text{ V}, \ R_{(\text{ILIM})} = 120 \text{ k}\Omega, \ \text{IMON} = \overline{\text{FLT}} = \text{OPEN}, \ C_{(\text{OUT})} = 1 \text{ }\mu\text{F}, \ C_{(\text{dVdT})} = \text{OPEN}.$ (All voltages referenced to GND. (unless otherwise noted))

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY VOLT	AGE					
V _(IN)	Operating input voltage		4.2		42	V
V _(PORR)	Internal POR threshold, rising		3.9	4	4.1	V
V _(PORHys)	Internal POR hysteresis		250	275	300	mV
IQ _(ON)		Enabled: V _(SHDN) = 2 V	190	300	390	μΑ
IQ _(OFF)	Supply current	$V_{(SHDN)} = 0 \text{ V}$	11	20	33	<u>.</u> μΑ
I _(VINR)	Reverse input supply current	$V_{(IN)} = -42 \text{ V}, V_{(OUT)} = 0 \text{ V}$		-	66	<u>.</u> μΑ
	GE LOCKOUT (UVLO) INPUT	(11)				
	Factory set V _(IN) undervoltage trip	V _(IN) rising, V _(UVLO) = 0 V	14.25	14.9	15.75	
$V_{(IN_UVLO)}$	level	$V_{\text{(IN)}}$ falling, $V_{\text{(UVLO)}} = 0 \text{ V}$	13.25	13.8	14.75	V
V _(SEL_UVLO)	Internal UVLO select threshold	(114)35 - (00/20)	180	200	240	mV
V _(UVLOR)	UVLO threshold voltage, rising		1.175	1.19	1.225	V
V _(UVLOF)	UVLO threshold voltage, falling		1.08	1.1	1.125	V
I _(UVLO)	UVLO input leakage current	0 V ≤ V _(UVLO) ≤ 42 V	-100	0	100	nA
, ,	DOWN (SHDN) INPUT	(010)				
V _(SHDN)	Output voltage	I _(SHDN) = 0.1 μA	2	2.7	3.4	V
V _(SHUTF)	SHDN threshold voltage for low IQ shutdown, falling	(CHUN) C. F. F.	0.55	0.76	0.94	V
I _(SHDN)	Leakage current	V _(SHDN) = 0.4 V	-10			μΑ
• •	GE PROTECTION (OVP) INPUT	т (зпын)				Pr
		V _(IN) rising, V _(OVP) = 0 V	31	32.6	34	
$V_{(IN_OVP)}$	Factory set $V_{(IN)}$ overvoltage trip level	$V_{\text{(IN)}}$ falling, $V_{\text{(OVP)}} = 0 \text{ V}$	28.5	30.3	31.5	V
V _(SEL_OVP)	Internal OVP select threshold	(IN)9, - (OVF)	180	200	240	mV
V _(OVPR)	Overvoltage threshold voltage, rising		1.17	1.19	1.225	V
V _(OVPF)	Overvoltage threshold, falling		1.085	1.1	1.125	
	OVP input leakage current	0 V ≤ V _(OVP) ≤ 4 V	-100	0	100	nA
I _(OVP) Output Ram	P CONTROL (dVdT)	0 V = V(OVP) = 4 V	-100		100	ПА
	dVdT charging current	$V_{(dVdT)} = 0 V$	4	4.7	5.5	μA
I _(dVdT)		,		14	5.5	Ω
R _(dVdT)	dVdT discharging resistance dVdT to OUT gain	$V_{(SHDN)} = 0 \text{ V, with } I_{(dVdT)} = 10 \text{ mA sinking}$	23.75	24.6	25.5	V/V
GAIN _(dVdT)	IIT PROGRAMMING (ILIM)	$V_{(OUT)}/V_{(dVdT)}$	23.13	24.0	20.0	V/V
				1		V
V _(ILIM)	ILIM bias voltage	B = 120 kO V V = 4 V	0.005	1	0.445	V
		$R_{(ILIM)} = 120 \text{ k}\Omega, V_{(IN)} - V_{(OUT)} = 1 \text{ V}$	0.085	0.1	0.115	
I _(OL)		$R_{(ILIM)} = 12 k\Omega, V_{(IN)} - V_{(OUT)} = 1 V$	0.95	1	1.05	A
(/		$R_{(ILIM)} = 8 k\Omega, V_{(IN)} - V_{(OUT)} = 1 V$	1.425	1.5	1.575	
	→ 1	$R_{(ILIM)} = 5.36 \text{ k}\Omega, V_{(IN)} - V_{(OUT)} = 1 \text{ V}$	2.11	2.23	2.35	
I _(OL_R-OPEN)		R _(ILIM) = OPEN, open resistor current limit (single point failure test: UL60950)			0.055	
I _(OL_R-SHORT)		R _(ILIM) = SHORT, shorted resistor current limit (single point failure test: UL60950)			0.095	
l _(OB)	Circuit breaker detection threshold	$R_{(ILIM)}$ = 120 k Ω , MODE = open	0.045	0.073	0.11	Δ
I _(CB)	Choult breaker detection threshold	R _(ILIM) = 5.36 kΩ, MODE = open	2	2.21	2.4	Α



7.5 Electrical Characteristics

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PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
		$R_{(ILIM)} = 120 \text{ k}\Omega, V_{(IN)} - V_{(OUT)} = 5 \text{ V}$	0.08	0.1	0.12	
I _(SCL)	Short-circuit current limit	$R_{(ILIM)} = 8 k\Omega, V_{(IN)} - V_{(OUT)} = 5 V$	1.425	1.5	1.575	Α
		$R_{(ILIM)} = 5.36 \text{ k}\Omega, V_{(IN)} - V_{(OUT)} = 5 \text{ V}$	2.11	2.23	2.35	
I _(FASTRIP)	Fast-trip comparator threshold			1.87 × I _(OL) + 0.015		А
CURRENT MO	NITOR OUTPUT (IMON)					
GAIN _(IMON)	Gain factor I _(IMON) : I _(OUT)	0.1 A ≤ I _(OUT) ≤ 2 A	72	78.28	85	μΑ/Α
PASS FET OUT	TPUT (OUT)				,	
		$0.1 \text{ A} \le I_{(OUT)} \le 2 \text{ A}, T_J = 25^{\circ}\text{C}$	140	150	160	
DON	ON IN to OUT total ON resistance	$0.1 \text{ A} \le I_{(OUT)} \le 2 \text{ A}, T_J = 85^{\circ}\text{C}$			210	m0
RON		0.1 A ≤ I _(OUT) ≤ 2 A, −40°C ≤ T _J ≤ +125°C	80	150	250	mΩ
		$V_{(IN)}$ = 42 V, $V_{(SHDN)}$ = 0 V, $V_{(OUT)}$ = 0 V, sourcing			12	
OUT leakage current in Off s	OUT leakage current in Off state	$V_{(IN)} = 0 \text{ V, } V(\overline{SHDN}) = 0 \text{ V, } V(OUT) = 24$ V, sinking			11	μΑ
		$V_{(IN)} = -42 \text{ V}, V_{(SHDN)} = 0 \text{ V}, V_{(OUT)} = 0$ V, sinking			50	
$V_{(REVTH)}$	$V_{(\text{IN})} - V_{(\text{OUT})}$ threshold for reverse protection comparator, falling		-15	-10	-5	mV
V(FWDTH)	$V_{(\text{IN})} - V_{(\text{OUT})}$ threshold for reverse protection comparator, rising		85	96	110	mV
FAULT FLAG (FLT): ACTIVE LOW				·	
R _(FLT)	FLT pull-down resistance	$V_{(OVP)} = 2 \text{ V}, I_{(FLT)} = 5 \text{ mA sinking}$	40	85	160	Ω
I _(FLT)	FLT input leakage current	0 V ≤ V _(FLT) ≤ 42 V	-200	,	200	nA
THERMAL SHU	JT DOWN (TSD)					
T _(TSD)	TSD threshold, rising			157		°C
T _(TSDhyst)	TSD hysteresis			10		°C
MODE					,	
		MODE = 402 kΩ to RTN	Current	limiting with	n latch	
MODE_SEL Thermal fault mode selection		MODE = Open	Circuit breaker mode with auto-retry			
		MODE = Short to RTN	Current I	imiting with retry	n auto-	

Product Folder Links: TPS2640



7.6 Timing Requirements

 $-40^{\circ}\text{C} \le T_{A} = T_{J} \le +125^{\circ}\text{C}, \ V_{(IN)} = 24 \ \text{V}, \ V_{(\overline{S}H\overline{DN})} = 2 \ \text{V}, \ R_{(ILIM)} = 120 \ \text{k}\Omega, \ \text{IMON} = \overline{FLT} = \text{OPEN}, \ C_{(OUT)} = 1 \ \mu\text{F}, \ C_{(dVdT)} = \text{OPEN}. \ (All voltages referenced to GND, (unless otherwise noted))}$

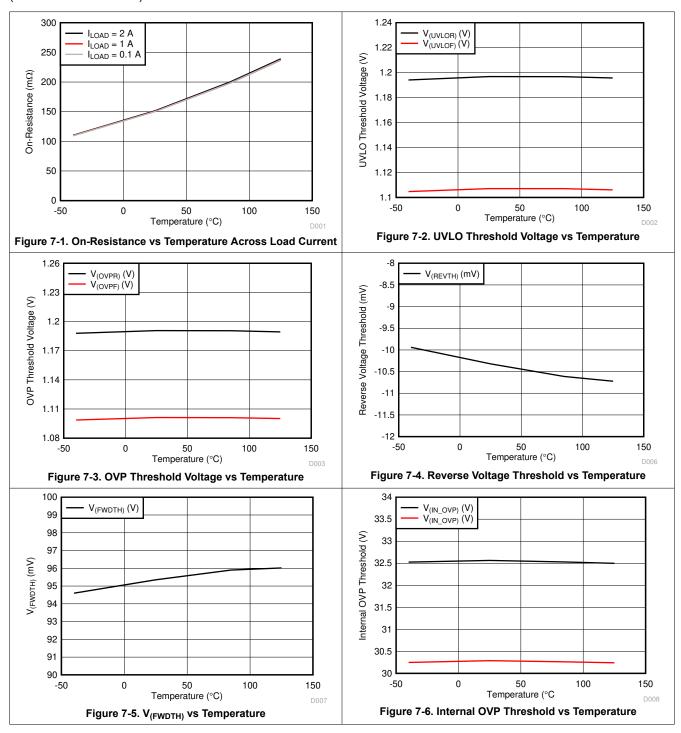
	renced to GND, (unless	,,	MIN NOM	MAX	UNIT	
N AND UVLO INF	PUT					
UVLO_t _{ON(dly)}		UVLO↑ (100 mV above $V_{(UVLOR)}$) to $V_{(OUT)}$ = 100 mV, $C(dvdt)$ = open	250		μs	
	UVLO turnon delay	UVLO↑ (100 mV above $V_{(UVLOR)}$) to $V_{(OUT)}$ = 100 mV, $C_{(dvdt)} \ge 10$ nF, $[C_{(dvdt)}$ in nF]	250 + 14.5 × C(dvdt)		μs	
UVLO_t _{off(dly)}	UVLO turnoff delay	UVLO↓ (100 mV below V _(UVLOF)) to FLT↓	10		μs	
SHUTDOWN CON	ITROL INPUT (SHDN)			'		
	SHUTDOWN exit	SHDN↑ to $V_{(OUT)}$ = 100 mV, $C_{(dvdt)}$ ≥ 10 nF, $[C_{(dvdt)}$ in nF]	250 + 14.5 × C(dvdt)		μs	
t _{SD(dly)}		SHDN↑ to V _(OUT) = 100 mV, C _(dvdt) = open	250		μs	
ı	SHUTDOWN entry delay	SHDN↓ (below V _(SHUTF)) to FLT↓	10		μs	
OVER VOLTAGE	PROTECTION INPUT (OVE	9)				
	OVP exit delay	OVP↓ (20 mV below V _(OVPF)) to V _(OUT) = 100 mV	200		μs	
^T OVP(dly)	OVP disable delay	OVP↑ (20 mV above V _(OVPR)) to FLT↓	6		μs	
CURRENT LIMIT	<u>'</u>			'		
t _{FASTTRIP(dly)}	Fast-trip comparator delay	I _(OUT) > I _(FASTRIP)	250		ns	
REVERSE PROTE	ECTION COMPARATOR			'		
t _{REV(dly)}		$(V_{(IN)} - V_{(OUT)})\downarrow$ (100-mV overdrive below $V_{(REVTH)}$) to internal FET turn OFF	1.5		µs	
	Reverse protection comparator delay	$(V_{(IN)} - V_{(OUT)})\downarrow (10\text{-mV} \text{ overdrive below } V_{(REVTH)}) \text{ to } FLT\downarrow$	45			
t _{FWD(dly)}		$(V_{(IN)} - V_{(OUT)})\uparrow$ (10-mV overdrive above $V_{(FWDTH)}$) to FLT \uparrow	70			
THERMAL SHUTE	OOWN					
t _{retry}	Retry delay in TSD		512		ms	
OUTPUT RAMP C	ONTROL (dVdT)					
t.n.c.T	Output ramp time	$\overline{\text{SHDN}}\uparrow \text{ to V}_{(OUT)}$ = 23.9 V, with $C_{(dVdT)}$ = 47 nF	10		- ms	
t _{dVdT}	Output famp time	SHDN↑ to $V_{(OUT)}$ = 23.9 V, with $C_{(dVdT)}$ = open	1.6			
FAULT FLAG (FL1	Γ)					
t _{CB(dly)}	FLT assertion delay in circuit breaker mode	MODE = OPEN, delay from $I_{(OUT)} > I_{(OL)}$ to FLT \downarrow	4		ms	
t _{CBretry(dly)}	Retry delay in circuit breaker mode	MODE = OPEN	540		ms	
t _{PGOODF}		Falling edge	875		μs	
	PGOOD delay (de- glitch) time	Rising edge, C _(dVdT) = open	1400			
t _{PGOODR}		Rising egde, C _(dVdT) ≥ 10 nF, [C _(dvdt) in nF]	875 + 20 × C _(dVdT)			

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7.7 Typical Characteristics

 $-40^{\circ}\text{C} \le T_{A} = T_{J} \le +125^{\circ}\text{C}, \ V_{(IN)} = 24 \ \text{V}, \ V_{(\overline{SHDN})} = 2 \ \text{V}, \ R_{(ILIM)} = 120 \ \text{k}\Omega, \ IMON = \overline{FLT} = OPEN, \ C_{(OUT)} = 1 \ \mu\text{F}, \ C_{(dVdT)} = OPEN \ (unless stated otherwise).$

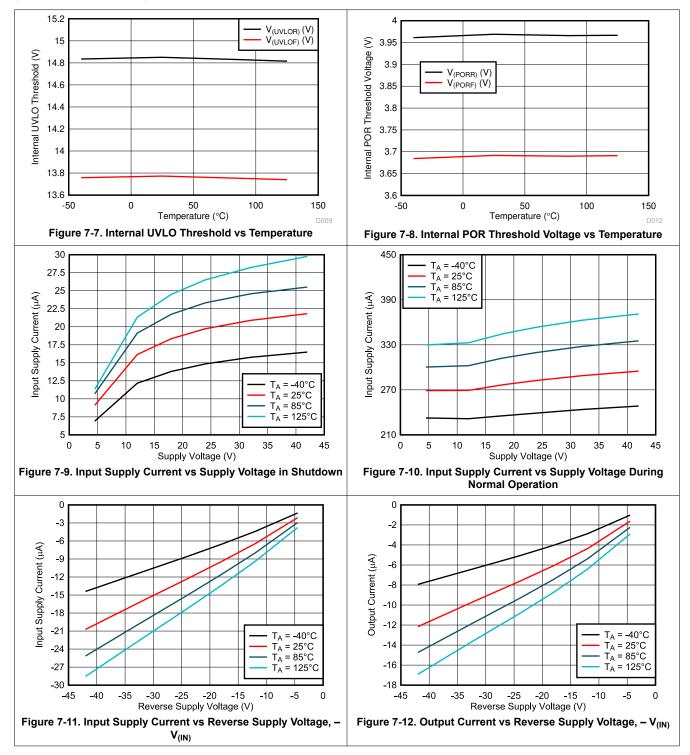


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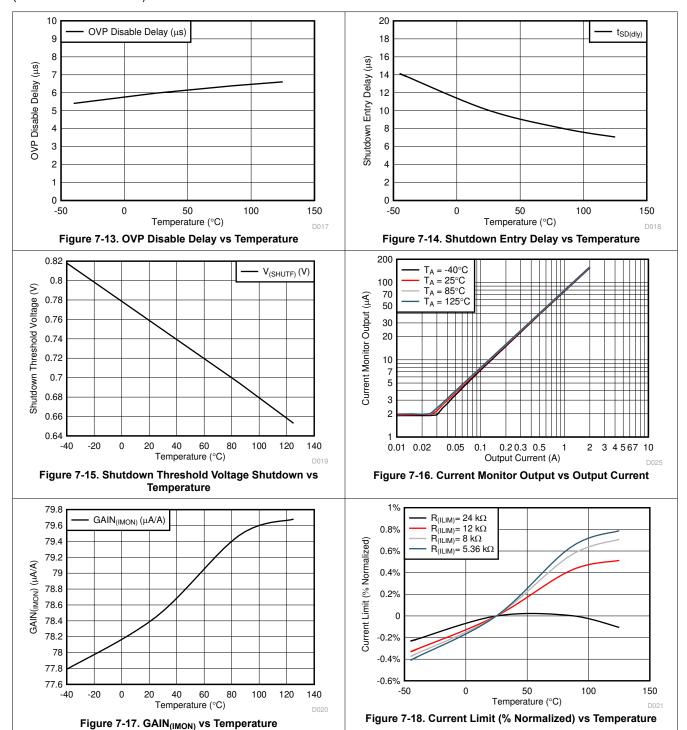
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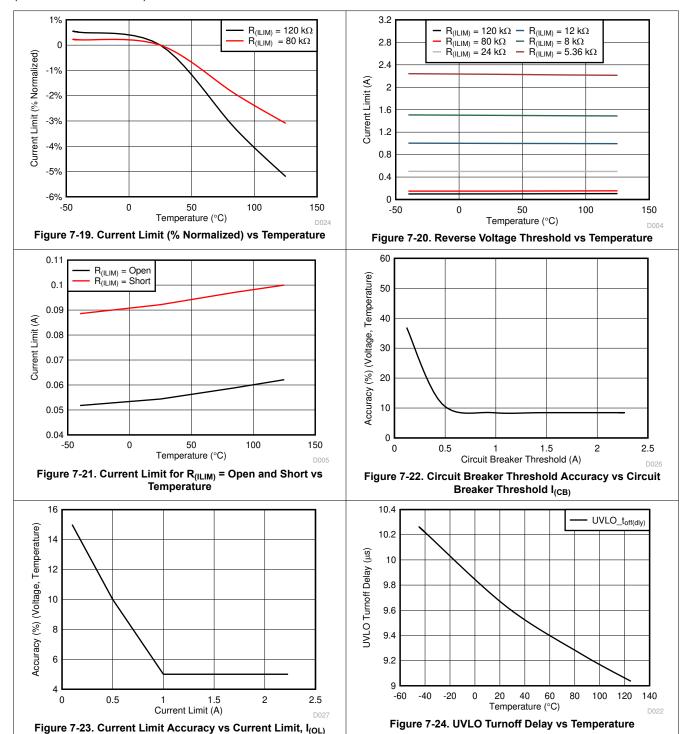
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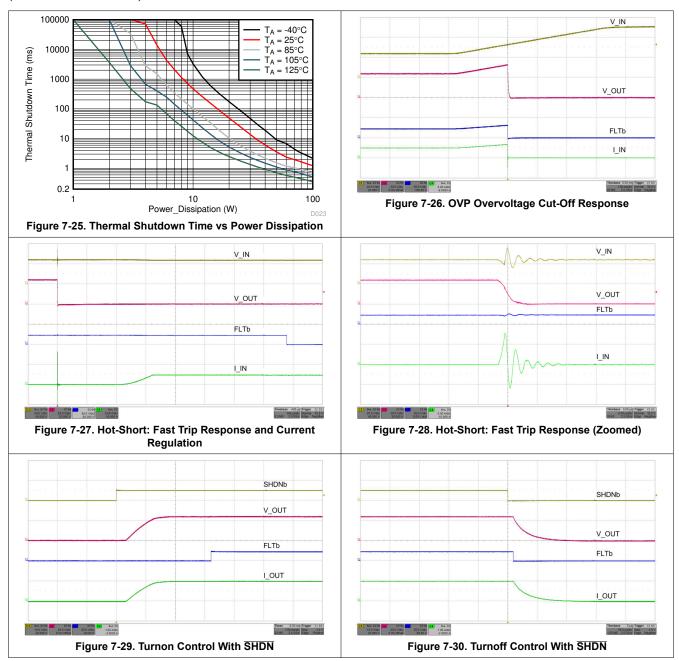
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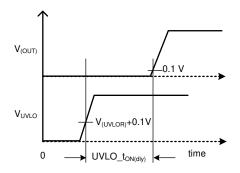
 $-40^{\circ}\text{C} \le \text{T}_{\text{A}} = \text{T}_{\text{J}} \le +125^{\circ}\text{C}, \ V_{(\text{IN})} = 24 \ \text{V}, \ V_{(\overline{\text{SHDN}})} = 2 \ \text{V}, \ R_{(\text{ILIM})} = 120 \ \text{k}\Omega, \ \text{IMON} = \overline{\text{FLT}} = \text{OPEN}, \ C_{(\text{OUT})} = 1 \ \mu\text{F}, \ C_{(\text{dVdT})} = \text{OPEN}$ (unless stated otherwise).

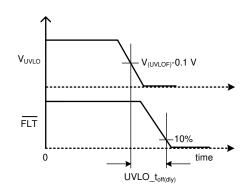


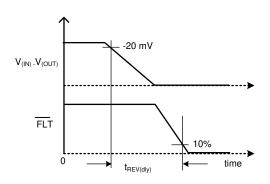
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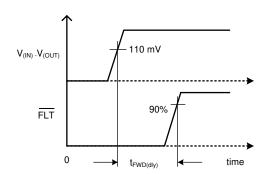
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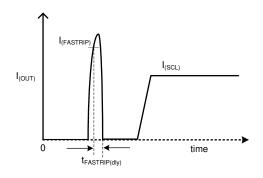
8 Parameter Measurement Information











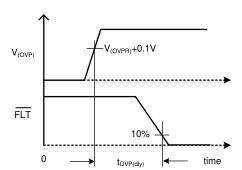


Figure 8-1. Timing Waveforms



9 Detailed Description

9.1 Overview

The TPS26400 is a high voltage industrial eFuse with integrated back-to-back MOSFETs and enhanced built-in protection circuitry. It provides robust protection for all systems and applications powered from 4.2 V to 42 V. The device can withstand ±42-V positive and negative supply voltages without damage. For hotpluggable boards, the device provides hot-swap power management with in-rush current control and programmable output voltage slew rate features. Load, source and device protections are provided with many programmable features including overcurrent, overvoltage, undervoltage. The precision overcurrent limit (±5% at 1 A) helps to minimize over design of the input power supply, while the fast response short circuit protection 250 ns (typical) immediately isolates the faulty load from the input supply when a short circuit is detected.

The internal robust protection control blocks of the TPS26400 along with its ±42-V rating helps to simplify the system designs for the surge compliance ensuring complete protection of the load and the device.

The device provides precise monitoring of voltage bus for brown-out and overvoltage conditions and asserts fault signal for the downstream system. The TPS26400 monitor functions threshold accuracy of ±3% ensures tight supervision of the supply bus, eliminating the need for a separate supply voltage supervisor chip.

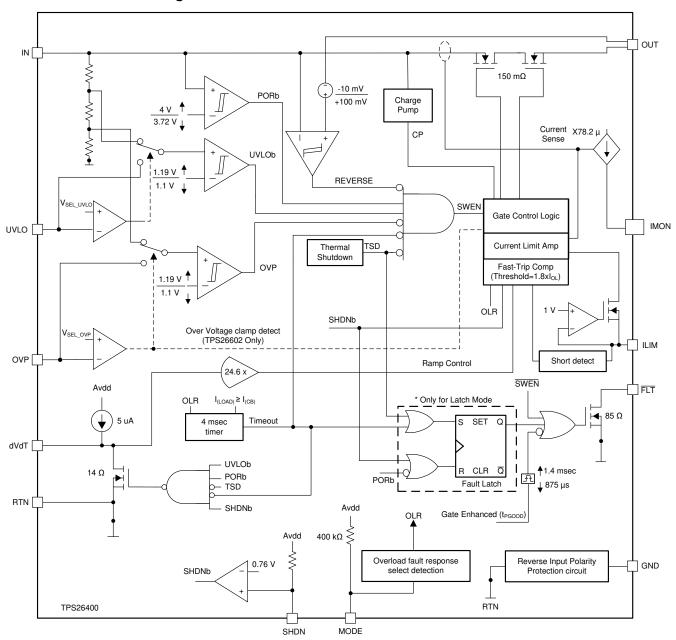
The device monitors V(IN) and V(OUT) to provide true reverse current blocking when a reverse condition or input power failure condition is detected. The TPS26400 is also designed to control redundant power supply systems. A pair of TPS26400 devices can be configured for Active ORing between the main power supply and the auxiliary power supply (see the System Examples section).

Additional features of the TPS26400 include:

- · Current monitor output for health monitoring of the system
- Electronic circuit breaker operation with overload timeout using MODE pin
- A choice of latch off or automatic restart mode response during current limit fault using MODE pin
- Over temperature protection to safely shutdown in the event of an overcurrent event
- De-glitched fault reporting for brown-out and overvoltage faults
- Look ahead overload current fault indication (see the Look Ahead Overload Current Fault Indicator section)

Product Folder Links: TPS2640

9.2 Functional Block Diagram



9.3 Feature Description

9.3.1 Undervoltage Lockout (UVLO)

Undervoltage comparator input. When the voltage at UVLO pin falls below $V_{(UVLOF)}$ during input power fail or input undervoltage fault, the internal FET quickly turns off and \overline{FLT} is asserted. The UVLO comparator has a hysteresis of 90 mV. To set the input UVLO threshold, connect a resistor divider network from IN supply to UVLO terminal to RTN as shown in Figure 9-1.



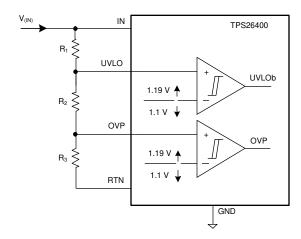


Figure 9-1. UVLO and OVP Thresholds Set by R₁, R₂ and R₃

The TPS26400 also features a factory set 15-V input supply undervoltage lockout $V_{(IN_UVLO)}$ threshold with 1-V hysteresis. This feature can be enabled by connecting the UVLO terminal directly to the RTN terminal. If the Under-Voltage Lock-Out function is not needed, the UVLO terminal must be connected to the IN terminal. UVLO terminal must not be left floating.

The device also implements an internal power ON reset (POR) function on the IN terminal. The device disables the internal circuitry when the IN terminal voltage falls below internal POR threshold $V_{(PORF)}$. The internal POR threshold has a hysteresis of 275 mV.

9.3.2 Overvoltage Protection (OVP)

The TPS26400 incorporate circuitry to protect the system during overvoltage conditions. A voltage more than $V_{(OVPR)}$ on OVP pin turns off the internal FET and protects the downstream load. To program the OVP threshold externally, connect a resistor divider from IN supply to OVP terminal to RTN as shown in Figure 9-1. The TPS26400 also feature a factory set 33-V Input overvoltage cut off $V_{(IN_OVP)}$ threshold with a 2-V hysteresis. This feature can be enabled by connecting the OVP terminal directly to the RTN terminal. Figure 7-26 illustrates the overvoltage cut-off functionality.

Programmable output overvoltage clamp can also be achieved using TPS26400 by connecting the resistor ladder

from Vout to OVP to RTN as shown in Figure 9-2 . This results in clamping of output voltage close to OVP setpoint

by resistors R4 and R5. as shown in Figure 9-3. This scheme will also help in achieving minimal system Iq during off state. For this OVP configurataion, use R4 > 90 k Ω .

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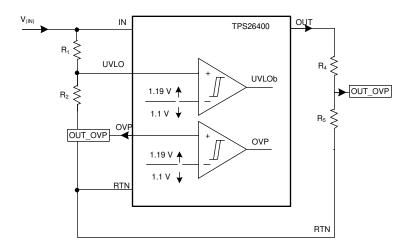


Figure 9-2. Programmable Output OV Clamp

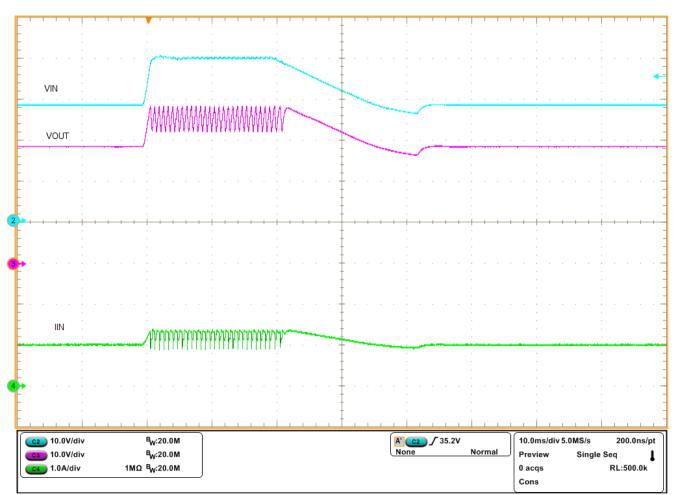


Figure 9-3. Programmable Output Overvoltage Clamp Response

9.3.3 Reverse Input Supply Protection

To protect the electronic systems from reverse input supply due to miswiring, often a power component like a schottky diode is added in series with the supply line as shown in Figure 9-4. These additional discretes result in a lossy and bulky protection solution. The TPS26400 devices feature fully integrated reverse input supply



protection and does not need an additional diode. These devices can withstand -42 V reverse voltage without damage. Figure 9-5 illustrates the reverse input polarity protection functionality.

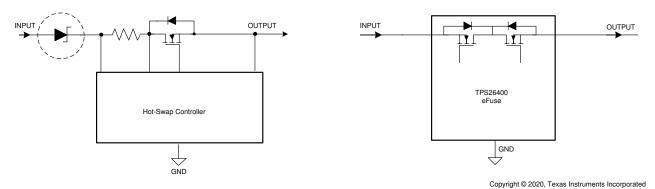


Figure 9-4. Reverse Input Supply Protection Circuits - Discrete vs TPS26400

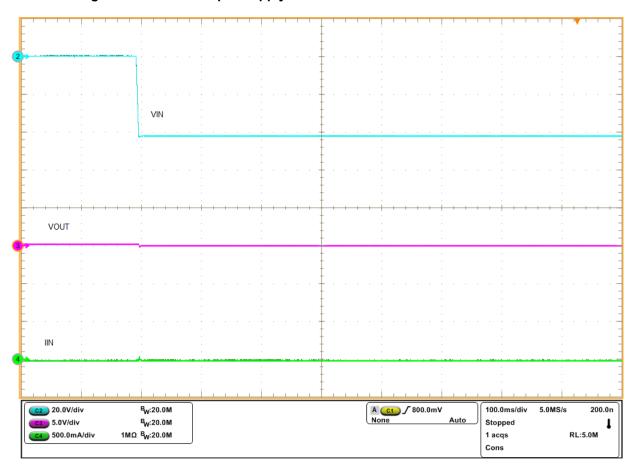


Figure 9-5. Reverse Input Supply Protection at -42 V

9.3.4 Hot Plug-In and In-Rush Current Control

The device is designed to control the in-rush current upon insertion of a card into a live backplane or other "hot" power source. This limits the voltage sag on the backplane's supply voltage and prevents unintended resets of the system power. The controlled start-up also helps to eliminate conductive and radiative interferences. An external capacitor connected from the dVdT pin to RTN defines the slew rate of the output voltage at power-on as shown in Figure 9-6 and Figure 9-7.

Product Folder Links: TPS2640

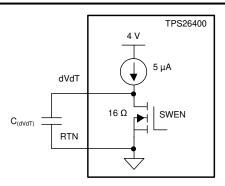


Figure 9-6. Output Ramp Up Time t_{dVdT} is Set by C_(dVdT)

The dVdT pin can be left floating to obtain a predetermined slew rate (t_{dVdT}) on the output. When the terminal is left floating, the devices set an internal output voltage ramp rate of 23.9 V/1.6 ms. A capacitor can be connected from dVdT pin to RTN to program the output voltage slew rate slower than 23.9 V/1.6 ms. Use Equation 1 and Equation 2 to calculate the external $C_{(dVdT)}$ capacitance.

Equation 1 governs slew rate at start-up.

$$I_{(dVdT)} = \left(\frac{C_{(dVdT)}}{Gain_{(dVdT)}}\right) \times \left(\frac{dV_{(OUT)}}{dt}\right)$$
(1)

where

• I_(dVdT) = 4.7 μA (typical) dV (OUT)

dt

• Gain_(dVdT) = dVdT to V_{OUT} gain = 24.6

The total ramp time (tdVdT) of V(OUT) for 0 to V(IN) can be calculated using Equation 2.

Figure 9-7. Hot Plug-In and In-Rush Current Control at 24-V Input

9.3.5 Overload and Short Circuit Protection

The device monitors the load current by sensing the voltage across the internal sense resistor. The FET current is monitored during start-up and normal operation.

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9.3.5.1 Overload Protection

The device offers following choices for the overload protection fault response:

- Active current limiting (Auto-retry/Latch-off modes)
- Electronic Circuit Breaker with overload timeout (Auto-retry)

See the configurations in Table 1 to select a specific overload fault response.

Table 9-1. Overload Fault Response Configuration Table

MODE PIN CONFIGURATION	OVERLOAD PROTECTION TYPE	DEVICE
Open	Electronic circuit breaker with auto-retry	TPS26400
Shorted to RTN	Active current limiting with auto-retry	TPS26400
A 402-kΩ resistor across MODE pin to RTN pin	Active current limiting with latch-off	TPS26400

9.3.5.1.1 Active Current Limiting

When the active current limiting mode is selected, during overload events, the device continuously regulates the load current to the overcurrent limit I(OL) programmed by the R(ILIM) resistor as shown in Equation 3.

$$I_{OL} = \frac{12}{R_{(ILIM)}}$$
 (3)

where

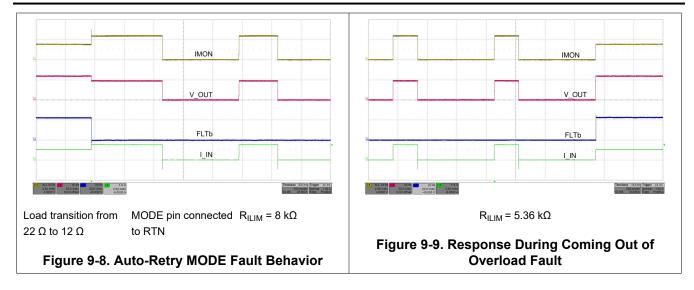
- I_(OL) is the overload current limit in Ampere
- $R_{(ILIM)}$ is the current limit resistor in $k\Omega$

During an overload condition, the internal current-limit amplifier regulates the output current to I(LIM). The FLT signal assert after a delay of 875 μ s. The output voltage droops during the current regulation, resulting in increased power dissipation in the device. If the device junction temperature reaches the thermal shutdown threshold (T(TSD)), the internal FET is turn off. The device configured in latch-off mode stays latched off until it is reset by either of the following conditions:

- Cycling V(IN) below V(PORF)
- Toggling SHDN

Whereas the device configured in auto-retry mode, commences an auto-retry cycle 512 ms after TJ < $[T(TSD) - 10^{\circ}C]$. The FLT signal remains asserted until the fault condition is removed and the device resumes normal operation. Figure 9-8 and Figure 9-9 illustrates behavior of the system during current limiting with auto-retry functionality.

Product Folder Links: TPS2640



9.3.5.1.2 Electronic Circuit Breaker with Overload Timeout, MODE = OPEN

In this mode, during overload events, the device allows the overload current to flow through the device until $I_{(LOAD)} < I_{(FASTRIP)}$. The circuit breaker threshold $I_{(CB)}$ can be programmed using the $R_{(ILIM)}$ resistor as shown in Equation 4.

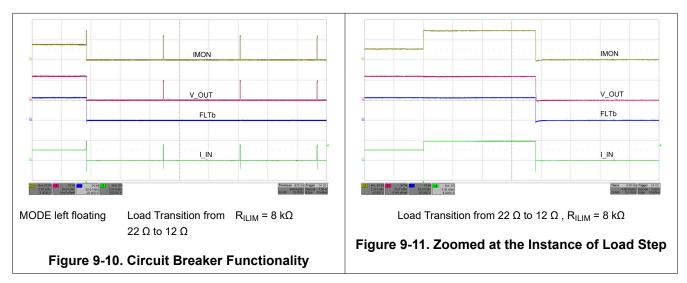
$$I(CB) = \frac{12}{R_{(ILIM)}} + 0.03A \tag{4}$$

where

- I_(CB) is circuit breaker current threshold in Ampere
- R_(ILIM) is the current limit resistor in kΩ

An internal timer starts when $I_{(CB)} < I_{LOAD} < I_{FASTRIP}$, and when the timer exceeds tCB(dly), the device turns OFF the internal FET and \overline{FLT} is asserted. After the internal FET is turned off,

the device commences an auto-retry cycle after 540 ms. The FLT signal remains asserted until the fault condition is removed and the device resumes normal operation. Figure 9-10 and Figure 9-11 illustrate behavior of the system during electronic circuit breaker with auto-retry functionality.

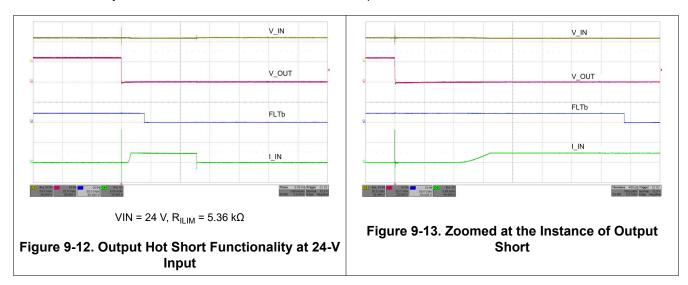


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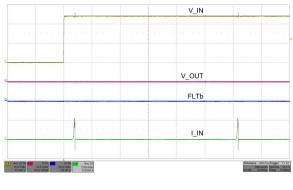
9.3.5.2 Short Circuit Protection

During a transient output short circuit event, the current through the device increases very rapidly. As the currentlimit amplifier cannot respond quickly to this event due to its limited bandwidth, the device incorporates a fast-trip comparator, with a threshold $I_{(FASTRIP)}$. The fast-trip comparator turns off the internal FET within 250 ns (typical), when the current through the FET exceeds $I_{(FASTRIP)}$ ($I_{(OUT)} > I_{(FASTRIP)}$), and terminates the rapid short-circuit peak current. The fast-trip threshold is internally set to 87% higher than the programmed overload current limit ($I_{(FASTRIP)} = 1.87 \times I_{(OL)} + 0.015$). The fast-trip circuit holds the internal FET off for only a few microseconds, after which the device turns back on slowly, allowing the current-limit loop to regulate the output current to $I_{(OL)}$. Then, device behaves similar to overload condition. Figure 9-12 and Figure 9-13 illustrate the behavior of the system when the current exceeds the fast-trip threshold.



9.3.5.2.1 Start-Up With Short-Circuit On Output

When the device is started with short-circuit on the output, it limits the load current to the current limit I(OL) and behaves similar to the overload condition. Figure 9-14 illustrates the behavior of the device in this condition. This feature helps in guick isolation of the fault and hence ensures stability of the DC bus



MODE pin connected to RTN VIN = 24 V R_{ILIM} = 5.36 k Ω

Figure 9-14. Start-Up With Short on Output

9.3.5.3 FAULT Response

The FLT open-drain output asserts (active low) under following conditions:

Fault events such as undervoltage, overvoltage, over load, reverse current and thermal shutdown conditions

Product Folder Links: TPS2640

When the device enters low current shutdown mode when SHDN is pulled low

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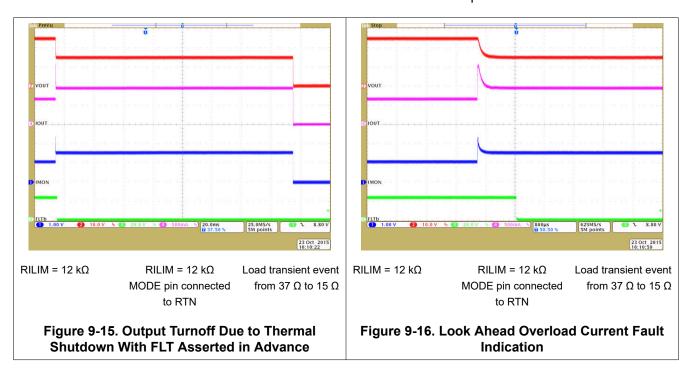
During start-up when the internal FET GATE is not fully enhanced

The device is designed to eliminate false reporting by using an internal "de-glitch" circuit for fault conditions without the need for an external circuitry.

The FLT signal can also be used as Power Good indicator to the downstream loads like DC-DC converters. An internal Power Good (PGOOD) signal is OR'd with the fault logic. During start-up, when the device is operating in dVdT mode, PGOOD and FLT remains low and is de-asserted after the dVdT mode is completed and the internal FET is fully enhanced. The PGOOD signal has deglitch time incorporated to ensure that internal FET is fully enhanced before heavy load is applied by the downstream converters. Rising deglitch delay is determined by tPGOOD(degl) = Maximum {(875 + 20 × $C_{(dVdT)}$), t_{PGOODR} }, where $C_{(dVdT)}$ is in nF and $t_{PGOOD(degl)}$ is in μ s. FLT can be left open or connected to RTN when not used. $V_{(IN)}$ falling below $V_{(PORF)} = 3.72$ V resets FLT.

9.3.5.3.1 Look Ahead Overload Current Fault Indicator

With the device configured in current limit operation and when the overload condition exists for more than t_{PGOODE}, 875 μs (typical), the FLT asserts to warn of impending turnoff of the internal FETs due to the subsequent thermal shutdown event. Figure 9-15 and Figure 9-16 depict this behavior. The FLT signal remains asserted until the fault condition is removed and the device resumes normal operation.



9.3.5.4 Current Monitoring

The current source at IMON terminal is internally configured to be proportional to the current flowing from IN to OUT. This current can be converted into a voltage using a resistor R_(IMON) from IMON terminal to RTN terminal. The IMON voltage can be used as a means of monitoring current flow through the system. The maximum voltage range (V_(IMONmax)) for monitoring the current is limited to minimum of ([V_(IN) – 1.5 V, 4 V]) to ensure linear output. This puts a limitation on maximum value of R_(IMON) resistor and is determined by Equation 5.

$$R(IMONmax) = \frac{Min [(V(IN) - 1.5), 4 V]}{1.8 \times I(LIM) \times GAIN(IMON)}$$
(5)

The output voltage at IMON terminal is calculated using Equation 6 and Equation 7.

For IOUT > 50 mA.

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$$V_{(IMON)} = [I_{(OUT)} \times GAIN_{(IMON)}] \times R_{(IMON)}$$
(6)

where,

- GAIN_(IMON) is the gain factor $I_{(IMON)}$: $I_{(OUT)} = 78.4 \mu A/A$ (Typical)
- I_(OUT) is the load current
- $I_{(MON OS)} = 2 \mu A$ (Typical)

For I_{OUT} < 50 mA (typical), use Equation 7.

$$V_{(IMON)} = (I_{(IMON OS)}) \times R_{(IMON)}$$
(7)

This pin must not have a bypass capacitor to avoid delay in the current monitoring information. In case of reverse input polarity fault, an external $100-k\Omega$ resistor is recommended between IMON pin and ADC input to limit the current through the ESD protection structures of the ADC.

9.3.5.5 IN, OUT, RTN, and GND Pins

The device has two pins for input (IN) and output (OUT). All IN pins must be connected together and to the power source. A ceramic bypass capacitor close to the device from IN to GND is recommended to alleviate bus transients. The recommended input operating voltage range is 4.2 to 42 V. Similarly all OUT pins must be connected together and to the load. V(OUT), in the ON condition, is calculated using Equation 8.

$$V_{(OUT)}V_{(IN)} - (RON) \times I_{(OUT)}$$
(8)

Where,

RON is the total ON resistance of the internal FETs.

GND pin must be connected to the system ground. RTN is the device ground reference for all the internal control blocks. Connect the TPS26400 support components: $R_{(ILIM)}$, $C_{(dVdT)}$, $R_{(IMON)}$, $R_{(MODE)}$ and resistors for UVLO and OVP with respect to the RTN pin. Internally, the device has reverse input polarity protection block between RTN and the GND terminal. Connecting RTN pin to GND pin disables the reverse input polarity protection feature and the TPS26400 gets permanently damaged when operated under this fault event.

9.3.5.6 Thermal Shutdown

The device has a built-in overtemperature shutdown circuitry designed to protect the internal FETs, if the junction temperature exceeds $T_{(TSD)}$. After the thermal shutdown event, depending upon the mode of fault response, the device either latches off or commences an auto-retry cycle 512 ms after $TJ < [T_{(TSD)} - 10^{\circ}C]$. During the thermal shutdown, the fault pin \overline{FLT} pulls low to indicate a fault condition.

9.3.5.7 Low Current Shutdown Control (SHDN)

The internal FETs and hence the load current can be switched off by pulling the \overline{SHDN} pin below 0.76 V threshold with a micro-controller GPIO pin or can be controlled remotely with an opto-isolator device as shown in Figure 9-17 and Figure 9-18. The device quiescent current reduces to 20 μ A (typical) in shutdown state. To assert SHDN low, the pull down must sink at least 10 μ A at 400 mV. To enable the device, \overline{SHDN} must be pulled up to atleast 1 V. Once the device is enabled, the internal FETs turnon with dVdT mode.

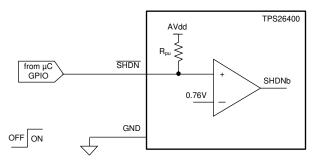


Figure 9-17. Shutdown Control

Product Folder Links: TPS2640

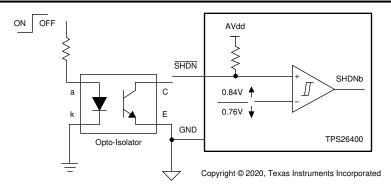


Figure 9-18. Opto-Isolator Shutdown Control

9.4 Device Functional Modes

Different operational modes of the device are explained in Table 9-2.

Table 9-2. Device Operational Differences Under Different MODE Configurations

Table 9-2. Device Operational Differences Officer Different MODE Configurations						
MODEPIN CONFIGURATION	MODE CONNECTED TO RTN (CURRENT LIMIT WITH AUTO- RETRY)	A 402-kΩ RESISTOR CONNECTED BETWEEN MODE AND RTN PINS (CURRENT LIMIT WITH LATCHOFF)	MODE PIN = OPEN (CIRCUIT BREAKER WITH AUTO-RETRY)			
	Inrush current controlled by dVdT					
	Inrush limited to $I_{(OL)}$ level as set by $R_{(ILIM)}$	Inrush limited to I _(OL) level as set by R _(ILIM)	Inrush limited to I _(OL) level as set by R _(ILIM)			
Start-up			Fault timer runs when current is limited to I _(OL)			
			Fault timer expires after t _{CB(dly)} causing the FETs to turnoff			
	If TJ > T _(TSD) , device turns off					
	Current is limited to $I_{(OL)}$ level as set by $R_{(ILIM)}$	Current is limited to $I_{(OL)}$ level as set by $R_{(ILIM)}$	Current is allowed through the device if I _(LOAD) < I _(FASTTRIP)			
	Power dissipation increases as $V_{(IN)} - V_{(OUT)}$ increases	Power dissipation increases as $V_{(IN)} - V_{(OUT)}$ increases	Fault timer runs when the current increases above I _(OL)			
Overcurrent response			Fault timer expires after t _{CB(dly)} causing the FETs to turnoff			
	Device turns off when TJ > T _(TSD)	Device turns off when TJ > T _(TSD)	Device turns off if T _J > T _(TSD) before timer expires			
	Device attempts restart 540 ms after TJ < [T _(TSD) – 10°C]	Device remains off	TPS26400 device attempts to restart 540 ms after $T_J < [T_{(TSD)} - 10^{\circ}C]$			
Short-circuit response	Fast turnoff when I _(LOAD) > I _(FASTRIP)					
Short-dicuit response	Quick restart and current limited to I _(OL) , follows standard start-up					

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10 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

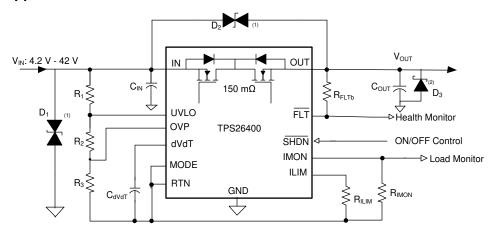
10.1 Application Information

The TPS26400 is an industrial eFuse, typically used for Hot-Swap and Power rail protection applications. It operates from 4.2 V to 42 V with programmable current limit, overvoltage, undervoltage and reverse polarity protection. The device aids in controlling in-rush current and provides robust protection against reverse current and filed miss-wiring conditions for systems such as PLCs, Industrial PCs, Control and Automation and Sensors. The device also provides robust protection for multiple faults on the system rail.

The Detailed Design Procedure section can be used to select component values for the device.

A spreadsheet design tool TPS26400 Design Calculator is available in the web product folder.

10.2 Typical Application



Note

- 1. Optional TVS Diodes (D1 and D2) for Power Line Surge IEC61000-4-5 [±500 V, 2 Ω].
- 2. Optional Schotky Diode (D3) for output short circuit protection with inductlive loads and cables.

Figure 10-1. 24-V, 1-A eFuse Input Protection Circuit for Industrial PLC CPU

10.2.1 Design Requirements

Table 3 shows the Design Requirements for current input protection with TPS26610.

Table 10-1. Design Requirements

DESIGN PARAMETER	EXAMPLE VALUE	
I _(IN)	Input current	±20 mA
V _(IN)	Input voltage	–V _s to 50 V
V _(OUT)	OutPut voltage	±V _s
I _(LIM)	Current limit	±30 mA
R _{Burden}	Burden resistance	50 to 250 Ω

Product Folder Links: TPS2640

10.2.2 Detailed Design Procedure

10.2.2.1 Step by Step Design Procedure

To begin the design process, the designer needs to know the following parameters:

- Input operating voltage range
- · Maximum output capacitance
- · Maximum current limit
- Load during start-up
- Maximum ambient temperature

This design procedure below seeks to control junction temperature of the device in both steady state and start-up conditions by proper selection of the output ramp-up time and associated support components. The designer can adjust this procedure to fit the application and design criteria.

10.2.2.2 Undervoltage Lockout and Overvoltage Set Point

The undervoltage lockout (UVLO) and overvoltage trip point are adjusted using an external voltage divider network of R1, R2 and R3 connected between IN, UVLO, OVP and RTN pins of the device. The values required for setting the undervoltage and overvoltage are calculated by solving Equation 9 and Equation 10.

$$V(OVPR) = \frac{R_3}{R_1 + R_2 + R_3} \times V(OV)$$
(9)

$$V(UVLOR) = \frac{R_2 + R_3}{R_1 + R_2 + R_3} \times V(UV)$$
 (10)

For minimizing the input current drawn from the power supply $\{I_{(R123)} = V_{(IN)}/(R1+R2+R3)\}$, it is recommended to use higher value resistance for R_1 , R_2 and R_3 .

However, the leakage current due to external active components connected at resistor string can add error to these calculations. So, the resistor string current, $I_{(R123)}$ must be chosen to be 20x greater than the leakage current of UVLO and OVP pins.

The UVLO and the OVP pins can also be connected to the RTN pin to enable the internal default $V_{(OV)}$ = 33 V and $V_{(UV)}$ = 15 V.

The power failure is detected on falling edge of the supply. This threshold voltage is 7.5% lower than the rising threshold, $V_{(UV)}$. The voltage at which the device detects power fail can be calculated using Equation 12.

$$V_{(PFAIL)} 0.925 \times V_{(UV)} \tag{11}$$

10.2.2.3 Programming Current Monitoring Resistor—R_{IMON}

The voltage at IMON pin $V_{(IMON)}$ represents the voltage proportional to the load current. This can be connected to an ADC of the downstream system for health monitoring of the system. The $R_{(IMON)}$ must be configured based on the maximum input voltage range of the ADC used. $R_{(IMON)}$ is set using Equation 12.

$$R(IMON) = \frac{V(IMON max)}{I(LIM) \times 75 \times 10^{-6}}$$
(12)

For $I_{(LIM)}$ = 1 A, and considering the operating voltage range of ADC from 0 V to 2.5 V, $V_{(IMONmax)}$ is 2.5 V and $R_{(IMON)}$ is determined by Equation 13.

$$R(IMON) = \frac{2.5}{1 \times 75 \times 10^{-6}} = 33.3 \text{k}\Omega$$
 (13)

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Selecting the $R_{(IMON)}$ value less than determined ensures that ADC limits are not exceeded for maximum value of the load current. Choose the closest standard 1% resistor value: $R_{(IMON)}$ = 33.2 k Ω .

If current monitoring up to I_(FASTRIP) is desired, R_(IMON) can be reduced by a factor of 1.8 as shown in Equation 5.

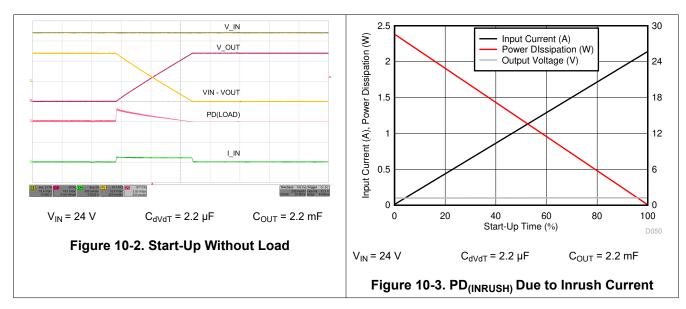
10.2.2.4 Setting Output Voltage Ramp Time—(t_{dVdT})

For a successful design, the junction temperature of the device must be kept below the absolute-maximum rating during dynamic (start-up) and steady state conditions. The dynamic power dissipation is often an order magnitude greater than the steady state power dissipation. It is important to determine the right start-up time and the in-rush current limit for the system to avoid thermal shutdown during start-up with and without load.

The ramp-up capacitor $C_{(dVdT)}$ is calculated considering the two possible cases:

10.2.2.4.1 Case 1: Start-Up Without Load—Only Output Capacitance C_(OUT) Draws Current During Start-Up

During start-up, as the output capacitor charges, the voltage difference across the internal FET decreases, and the power dissipation decreases. Typical ramp-up of the output voltage, inrush current and instantaneous power dissipated in the device during start-up are shown in Figure 10-2. The average power dissipated in the device during start-up is equal to the area of triangular plot (red curve in Figure 10-3) averaged over t_{dVdT}.



The inrush current is determined as shown in Equation 14.

$$I = C \times \frac{dV}{dT} \ge I(\text{INRUSH}) = C(\text{OUT}) \times \frac{V(\text{IN})}{\text{tdVdT}} \tag{14}$$

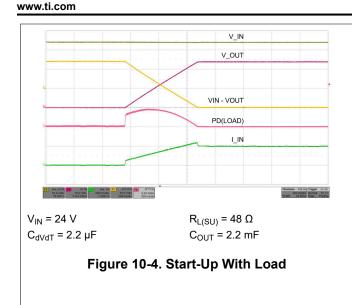
Average power dissipated during start-up is given by Equation 15.

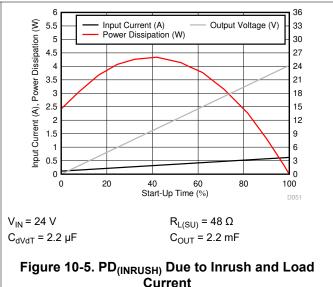
$$PD_{(INRUSH)} 0.5 \times V_{(IN)} \times I_{(INRUSH)}$$
(15)

Equation 15 assumes that the load does not draw any current until the output voltage reaches its final value.

10.2.2.4.2 Case 2: Start-Up With Load—Output Capacitance C(OUT) and Load Draws Current During Start-Up

When the load draws current during the turnon sequence, additional power is dissipated in the device. Considering a resistive load $R_{L(SU)}$ during start-up, typical ramp-up of output voltage, load current and the instantaneous power dissipation in the device are shown in Figure 10-4. Instantaneous power dissipation with respect to time is plotted in Figure 10-5. The additional power dissipation during start-up is calculated using Equation 16.





$$P_{D(LOAD)} = \frac{1}{6} \times \frac{V(IN)^2}{R_{L(SU)}}$$
(16)

Total power dissipated in the device during start-up is given by Equation 17.

$$PD_{(STARTUP)} PD_{(INRUSH)} = PD_{(LOAD)}$$
(17)

Total current during start-up is given by Equation 18.

$$I_{(STARTUP)} = I_{(INRUSH) \div} I_{L(t)}$$
(18)

For the design example under discussion,

Select the inrush current $I_{(INRUSH)} = 0.1$ A and calculate t_{dVdT} using Equation 19.

$$t(dVdT) = 2.2m \times \frac{24}{0.1} = 0.528s \tag{19}$$

For a given start-up time, C_{dVdT} capacitance value is calculated using Equation 20.

$$C(\text{dVdT}) = \frac{t(\text{dVdT})}{8 \times 10^3 \times V(\text{IN})} = 2.7 \mu F \tag{20}$$

where

- $t_{(dVdT)} = 0.528 s$
- V_(IN) = 24 V

Choose the closest standard value: 2.2-µF/16-V capacitor.

The inrush power dissipation is calculated, using Equation 21.

$$PD_{(INRUSH)} = 0.5 \times V_{(IN)} = I_{(INRUSH)} 1.2W$$
 (21)

where

V_(IN) = 24 V

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I_(INRUSH) = 0.1 A

Considering the start-up with $48-\Omega$ load, the additional power dissipation, is calculated using Equation 22.

$$P_{D(LOAD)} = \left(\frac{1}{6}\right) \times \frac{V(IN)^2}{R_L(SU)} = 2 \text{ W}$$
(22)

where

- V_(IN) = 24 V
- R_{L(SU)} = 48 Ω

The total device power dissipation during start-up is given by Equation 23.

$$P_{D(STARTUP)} = P_{D(INRUSH)} + P_{D(LOAD)} = 3.2W$$
(23)

where

- P_{D(INRUSH)} = 1.2 W
- P_{D(LOAD)} = 2 W

The power dissipation with or without load, for a selected start-up time must not exceed the thermal shutdown limits as shown in Figure 10-6.

From the thermal shutdown limit graph, at T_A = 85°C, thermal shutdown time for 3.2 W is close to 28000 ms. It is safe to have a minimum 30% margin to allow for variation of the system parameters such as load, component tolerance, input voltage and layout. Selected 2.2- μ F C_{dVdT} capacitor and 528-ms start-up time (t_{dVdT}) are within limit for successful start-up with 48- Ω load.

Higher value $C_{(dVdT)}$ capacitor can be selected to further reduce the power dissipation during start-up.

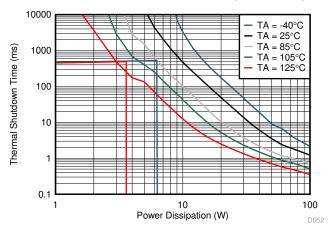


Figure 10-6. Thermal Shutdown Time vs Power Dissipation

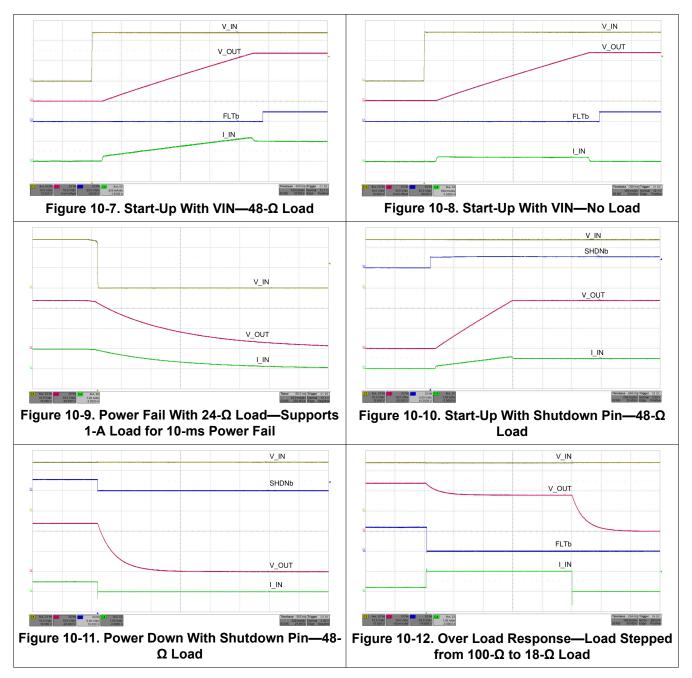
10.2.2.4.3 Support Component Selections—R_{FLTb} and C_(IN)

The R_{FLTb} serves as pull-up for the open-drain fault output. The current sink by this pin must not exceed 10 mA (see the Absolute Maximum Ratings table). Typical resistance value in the range of 10 k Ω to 100 k Ω is recommended for RFLTb. The C_{IN} is a local bypass capacitor to suppress noise at the input. Typical capacitance value in the range of 0.1 μ F to 1 μ F is recommended for $C_{(IN)}$.

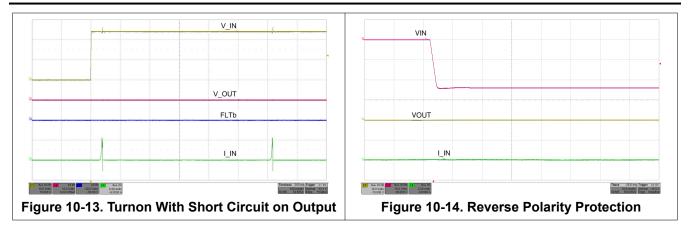
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10.2.3 Application Curves







10.3 System Examples

10.3.1 Acive ORing Operation

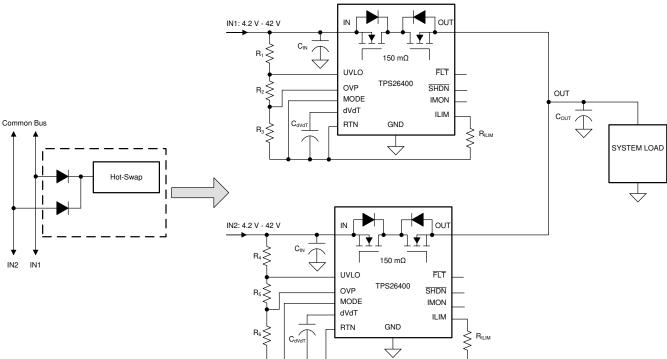


Figure 10-15. Active ORing Application Schematic

Figure 10-15 shows a typical redundant power supply configuration of the system. Schottky ORing diodes have been popular for connecting parallel power supplies, such as parallel operation of wall adapter with a battery or a hold-up storage capacitor. The disadvantage of using ORing diodes is high voltage drop and associated power loss. The TPS26400 with integrated, N-channel back to back FETs provide a simple and efficient solution.

A fast reverse comparator controls the internal FET and it is turned ON or OFF with hysteresis as shown in Figure 10-16. The internal FET is turned off within 1.5 μ s (typical) as soon as $V_{(IN)} - V_{(OUT)}$ falls below –110 mV. It turns on within 40 μ s (typical) once the differential forward voltage $V_{(IN)} - V_{(OUT)}$ exceeds 100 mV. Figure 10-17 and Figure 10-18 show typical switch-over waveforms of Active ORing implementation using the TPS26400.

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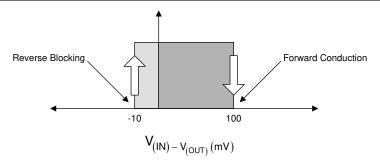
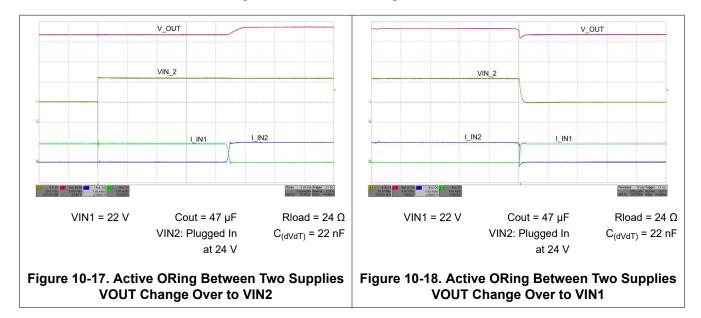


Figure 10-16. Active ORing Thresholds



Note

All control pins of the un-powered TPS26400 device in the Active ORing configuration will measure approximately 0.7 V drop with respect to GND. The system micro-controller should ignore IMON and FLT pin voltage measurements of this device when these signals are being monitored.

10.3.2 Field Supply Protection in PLC, DCS I/O Modules

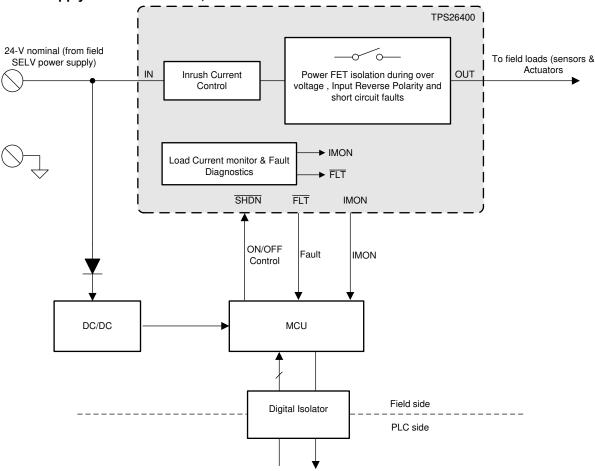


Figure 10-19. Power Delivery Circuit Block Diagram in I/O Modules

The PLC or Distributed Control System (DCS) I/O modules are often connected to an external field power supply to support higher power requirements of the field loads like sensors and actuators. Power-supply faults or miswiring can damage the loads or cause the loads not to operate correctly. The TPS26400 can be used as a front end protection circuit to protect and provide stable supply to the field loads. Under voltage, Over voltage and reverse polarity protection features of the TPS26400 prevent the loads to experience voltages outside the operating range, which can permanently damage the loads.

Field power supply is often connected to multiple I/O modules and is capable of delivering more current than a single I/O module can handle. Overcurrent protection scheme of the TPS26400 limits the current from the power supply to the module so that the maximum current does not rise above what the board is designed for. Fast short circuit protection scheme isolates the faulty load from the field supply quickly and prevents the field supply to dip and cause interrupts in the other I/O modules connected to the same field supply. High accurate (±5% at 1 A) current limit facilitates more I/O modules to be connected to field supply. Load current monitor (IMON) and fault indication (FLT) features facilitate continuous load monitoring.

The TPS26400 also acts as a smart diode with protection against reverse current during output side miswiring. Reverse current can potentially damage the field power supply and cause the I/O modules to run hot or may cause permanent damage.

If the field power supply is connected in reverse polarity (which is not unlikely as field power supplies are usually connected with screw terminals), field loads can permanently get damaged due to the reverse voltage. The reverse polarity protection feature of the TPS26400 prevents the reverse voltage to appear at the load side.

10.3.3 Simple 24-V Power Supply Path Protection

With the TPS26400, a simple 24-V power supply path protection can be realized using a minimum of three external components as shown in the schematic diagram in Figure 10-20. The external components required are: a $R_{(ILIM)}$ resistor to program the current limit, $C_{(IN)}$ and $C_{(OUT)}$ capacitors.

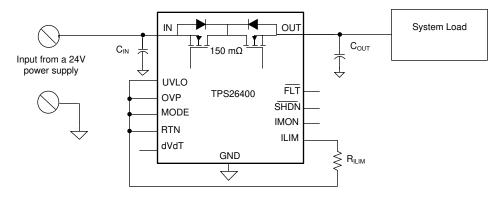


Figure 10-20. TPS2640 Configured for a Simple 24-V Supply Path Protection

Protection features with this configuration include:

- Load and device protection from reverse input polarity fault down to –42V
- 15 V (typical) rising under voltage lock-out threshold
- 33 V (typical) rising overvoltage cut-off threshold
- Inrush current control with 24-V/1.6-ms output voltage slew rate
- · Reverse Current Blocking
- · Accurate current limiting with Auto-Retry

10.4 Do's and Dont's

- Do not connect RTN to GND. Connecting RTN to GND disables the Reverse Polarity protection feature
- Connect the TPS26400 support components R_(ILIM), C_(dVdT), R_(IMON), R_(MODE) and UVLO, OVP resistors with respect to RTN pin
- Connect device PowerPAD to the RTN plane for an enhanced thermal performance

11 Power Supply Recommendations

The TPS26400 eFuse is designed for the supply voltage range of 4.2 V \leq V_{IN} \leq 42 V. If the input supply is located more than a few inches from the device, an input ceramic bypass capacitor higher than 0.1 μ F is recommended. Power supply must be rated higher than the current limit set to avoid voltage droops during overcurrent and short circuit conditions

11.1 Transient Protection

In case of short circuit and over load current limit, when the device interrupts current flow, input inductance generates a positive voltage spike on the input and output inductance generates a negative voltage spike on the output. The peak amplitude of voltage spikes (transients) is dependent on value of inductance in series to the input or output of the device. Such transients can exceed the Abolsute Maximum Ratings of the device if steps are not taken to address the issue.

Typical methods for addressing transients include

- · Minimizing lead length and inductance into and out of the device
- Using large PCB GND plane
- · Schottky diode across the output to absorb negative spikes
- A low value ceramic capacitor ($C_{(IN)}$ to approximately 0.1 μF) to absorb the energy and dampen the transients.

The approximate value of input capacitance can be estimated with Equation 24.

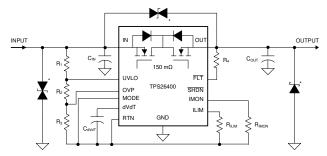
$$V_{\text{spike}(\text{Absolute})} = V_{\text{(IN)}} + I_{\text{(Load)}} \times \sqrt{\frac{L_{\text{(IN)}}}{C_{\text{(IN)}}}}$$
(24)

where

- V_(IN) is the nominal supply voltage
- I_(LOAD) is the load current
- L_(IN) equals the effective inductance seen looking into the source
- C_(IN) is the capacitance present at the input

Some applications may require additional Transient Voltage Suppressor (TVS) to prevent transients from exceeding the Abolsute Maximum Ratings of the device. These transients can occur during positive and negative surge tests on the supply lines. In such applications it is recommended to place atleast 1 μ F of input capacitor to limit the falling slew rate of the input voltage within a maximum of 15 V/ μ s.

The circuit implementation with optional protection components (a ceramic capacitor, TVS and schottky diode) is shown in Figure 11-1.



A. Optional components needed for suppression of transients

Figure 11-1. Circuit Implementation With Optional Protection Components



12 Layout

12.1 Layout Guidelines

- For all the applications, a 0.1 μF or higher value ceramic decoupling capacitor is recommended between IN terminal and GND.
- The optimum placement of decoupling capacitor is closest to the IN and GND terminals of the device. Care
 must be taken to minimize the loop area formed by the bypass-capacitor connection, the IN terminal, and the
 GND terminal of the IC. See Figure 12-1 and Figure 12-2 for PCB layout examples with HTSSOP and VQFN
 packages respectively.
- High current carrying power path connections must be as short as possible and must be sized to carry atleast twice the full-load current.
- RTN, which is the reference ground for the device must be a copper plane or island.
- Locate all the TPS26400 support components R_(ILIM), C_(dVdT), R_(IMON), and MODE, UVLO, OVP resistors close to their connection pin. Connect the other end of the component to the RTN with shortest trace length.
- The trace routing for the R_{ILIM} and R_(IMON) components to the device must be as short as possible to
 reduce parasitic effects on the current limit and current monitoring accuracy. These traces must not have any
 coupling to switching signals on the board.
- Protection devices such as TVS, snubbers, capacitors, or diodes must be placed physically close to the
 device they are intended to protect, and routed with short traces to reduce inductance. For example, a
 protection Schottky diode is recommended to address negative transients due to switching of inductive loads,
 and it must be physically close to the OUT and GND pins.
- Thermal Considerations: When properly mounted, the PowerPAD package provides significantly greater
 cooling ability. To operate at rated power, the PowerPAD must be soldered directly to the board RTN plane
 directly under the device. Other planes, such as the bottom side of the circuit board can be used to increase
 heat sinking in higher current applications. Designs that do not need reverse input polarity protection can
 have RTN, GND and PowerPAD connected together. PowerPAD in these designs can be connected to the
 PCB ground plane.

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12.2 Layout Example

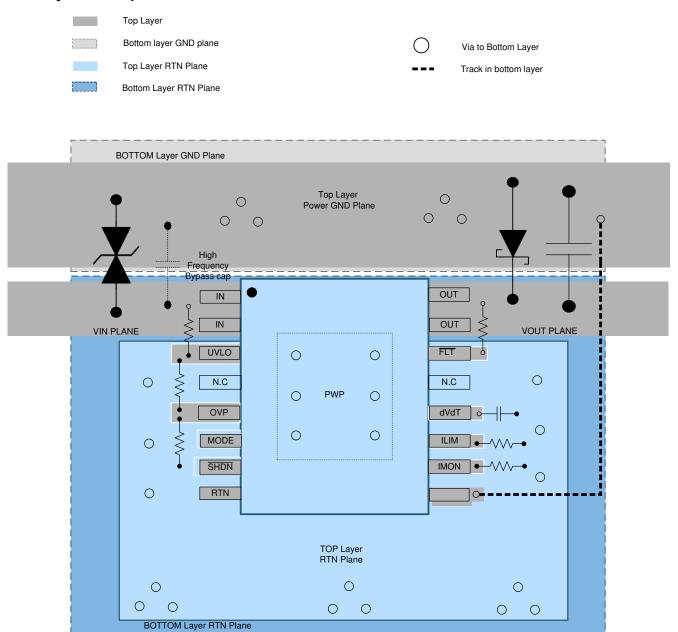


Figure 12-1. Typical PCB Layout Example With HTSSOP Package With a 2 Layer PCB



Top Layer

Bottom layer GND plane

Top Layer RTN Plane

Sottom Layer RTN Plane

Track in bottom layer

Bottom Layer RTN Plane

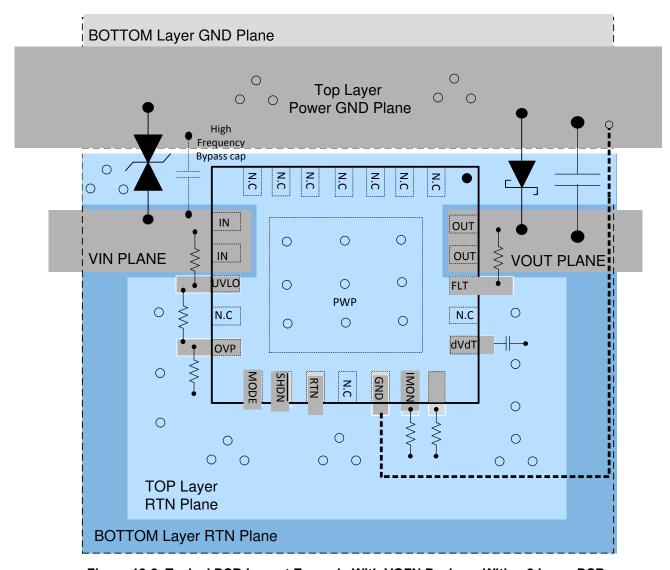


Figure 12-2. Typical PCB Layout Example With VQFN Package With a 2 Layer PCB



13 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

13.1 Device Support

For TPS26400 PSpice Transient Mode, see SLVMDF4.

For TPS26400 Design Calculator, see SLVRBG7.

13.2 Documentation Support

13.2.1 Related Documentation

For related documentation see the following:

- TPS26400-02EVM: Evaluation Module for TPS26400 User's Guide
- Power Multiplexing Using Load Switches and eFuses

13.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

13.4 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

13.5 Trademarks

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13.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

13.7 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: TPS2640

www.ti.com 28-Sep-2021

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TPS26400PWPR	ACTIVE	HTSSOP	PWP	16	2000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	26400	Samples
TPS26400RHFR	ACTIVE	VQFN	RHF	24	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TPS 26400	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

www.ti.com 28-Sep-2021

PACKAGE MATERIALS INFORMATION

www.ti.com 5-Dec-2023

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS26400PWPR	HTSSOP	PWP	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TPS26400RHFR	VQFN	RHF	24	3000	330.0	12.4	4.3	5.3	1.3	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

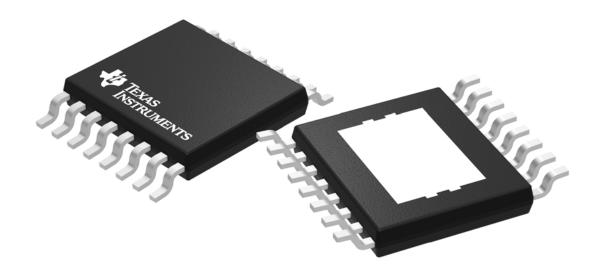
www.ti.com 5-Dec-2023



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS26400PWPR	HTSSOP	PWP	16	2000	350.0	350.0	43.0
TPS26400RHFR	VQFN	RHF	24	3000	367.0	367.0	35.0

PLASTIC SMALL OUTLINE



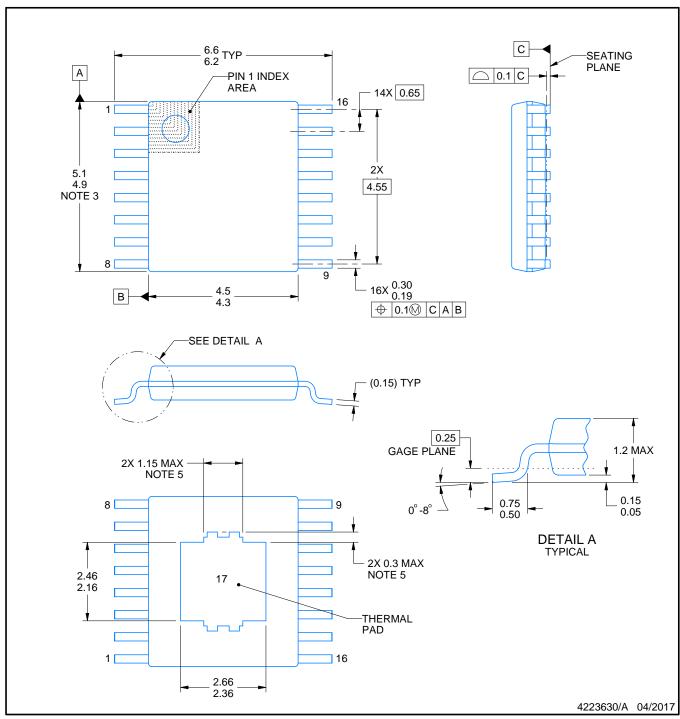
Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





PowerPAD[™] TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

PowerPAD is a trademark of Texas Instruments.

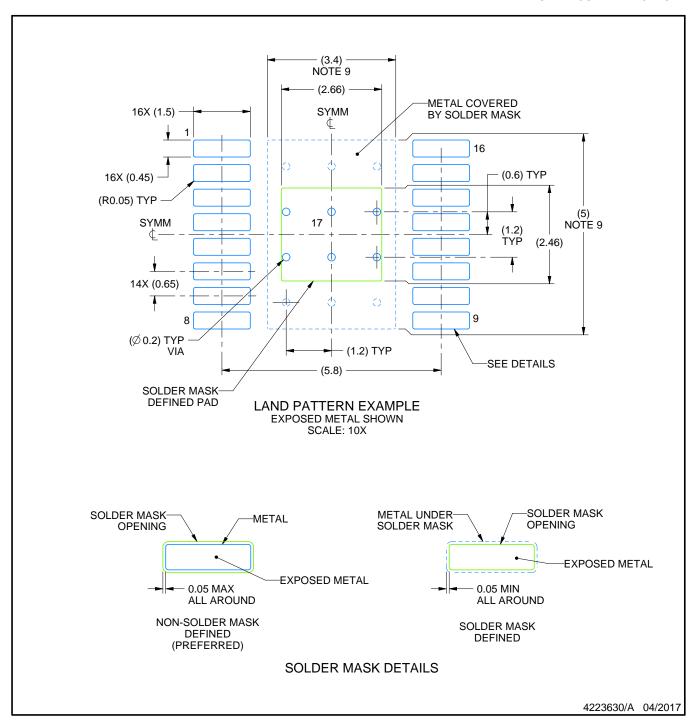
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-153.
- 5. Features may differ or may not be present.



SMALL OUTLINE PACKAGE

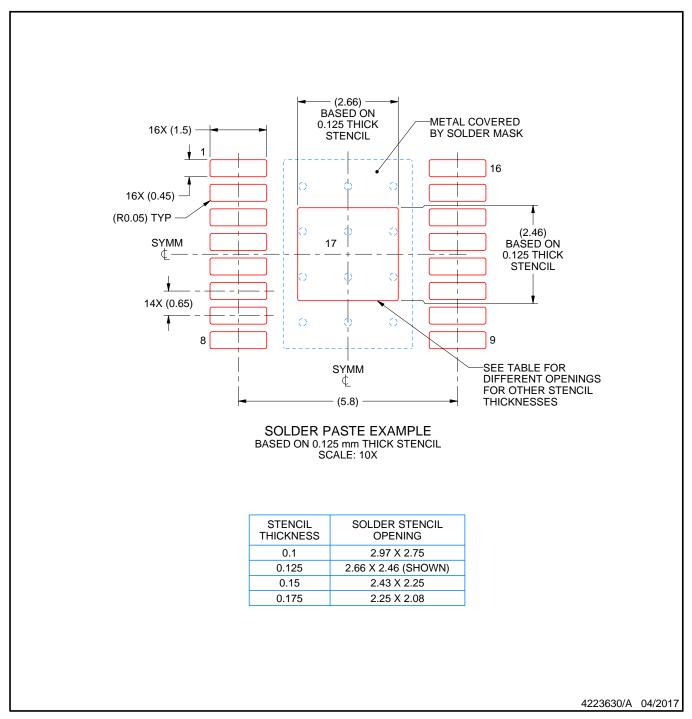


NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 (www.ti.com/lit/slma002) and SLMA004 (www.ti.com/lit/slma004).
- 9. Size of metal pad may vary due to creepage requirement.
- 10. Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.



SMALL OUTLINE PACKAGE



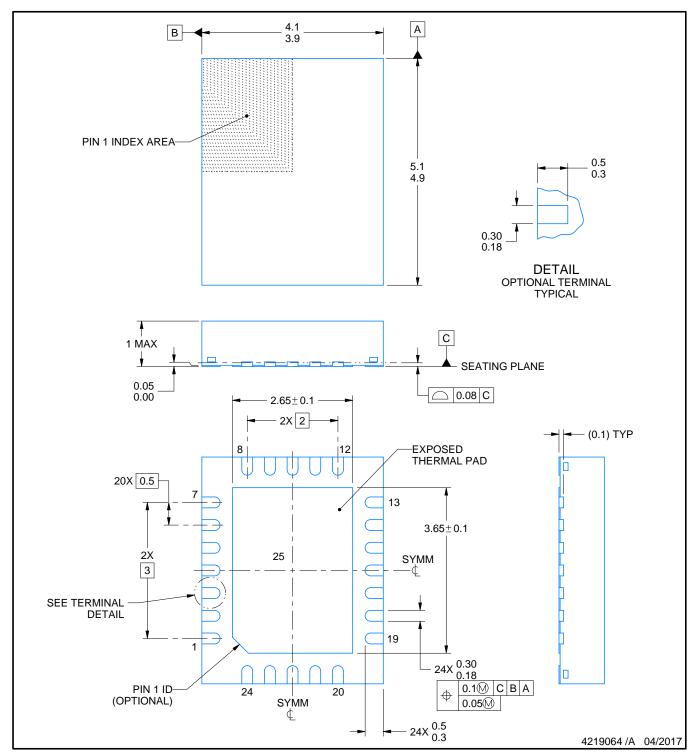
NOTES: (continued)

- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.





PLASTIC QUAD FLATPACK - NO LEAD



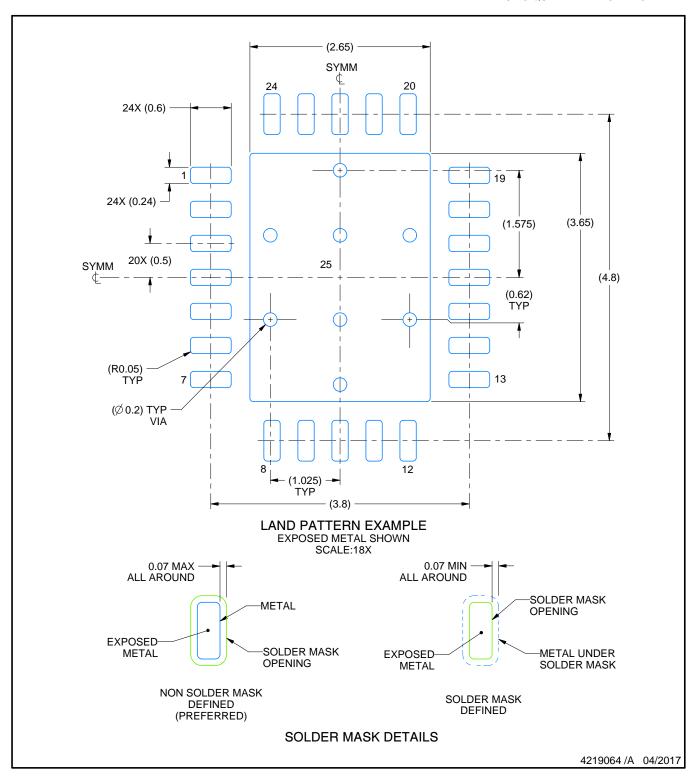
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK - NO LEAD

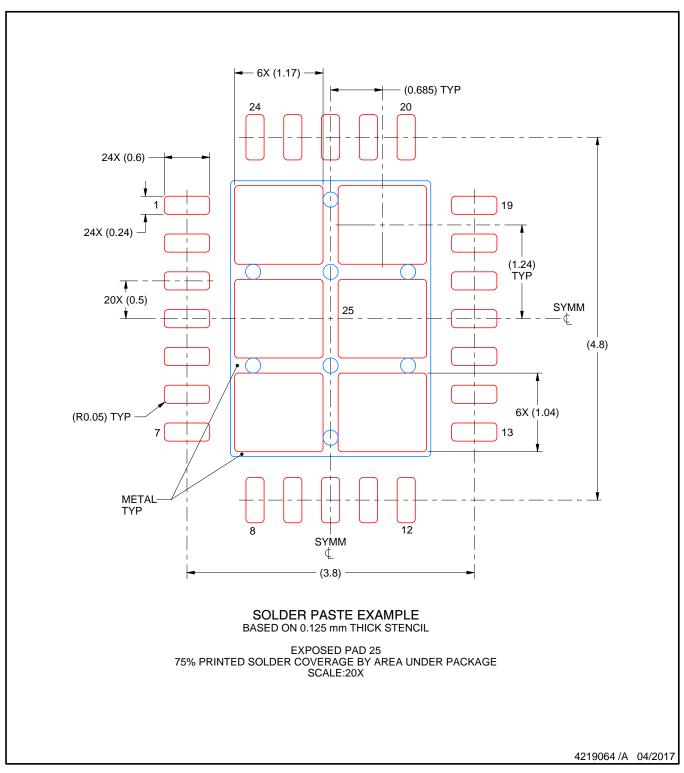


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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